



Docket No.: 058604-0029

PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of : Customer Number: 20277  
Shigeo MURAKAMI : Confirmation Number: 7075  
Application No.: 10/615,294 : Group Art Unit: 2625  
Filed: July 09, 2003 : Examiner: Not Yet Assigned  
For: PRINT QUALITY MEASURING METHOD AND PRINT QUALITY MEASURING  
APPARATUS

**INFORMATION DISCLOSURE STATEMENT**

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits. No certification or fee is required.

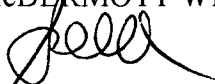
Each reference was first cited in a corresponding European Search Report and its relevance is discussed therein. A copy of the European Search Report is attached for the Examiner's information.

10/615,294

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

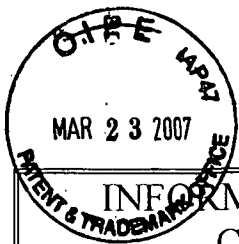
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**Please recognize our Customer No. 20277  
as our correspondence address.**



SHEET 1 OF 1

<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  (PTO-1449)				ATTY. DOCKET NO. <b>058604-0029</b>		SERIAL NO. <b>10/615,294</b>		
				APPLICANT <b>Shigeo MURAKAMI</b>				
				FILING DATE <b>July 09, 2003</b>		GROUP <b>2625</b>		
<b>U.S. PATENT DOCUMENTS</b>								
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
/V.H./		US 5,774,635	06-30-1998	KUUSISTO et al.				
/V.H./		US 2001/0010191 A1	08-02-2001	STEINBACHER				
/V.H./		US 5,450,165	09-12-1995	HENDERSON				
		US						
		US						
		US						
<b>FOREIGN PATENT DOCUMENTS</b>								
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number + -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No	
/V.H./		EP 0 803 356 A2	10-29-1997	ADVANCED VISION TECHNOLOGY (A.V.T.) LTD.			X	
/V.H./		EP 0 142 470 A1	05-22-1985	GRETAG AKTIENGESELLSCHAFT				X
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>								
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.						
/V.H./		European Search Report issued in corresponding European Patent Application No. 03015450.4 - 1228, dated January 30, 2007						
/Vu Hang/ EXAMINER				07/24/2008 DATE CONSIDERED				

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.